



**ALPHA & OMEGA**  
SEMICONDUCTOR, LTD



## AOD460

### N-Channel Enhancement Mode Field Effect Transistor

#### General Description

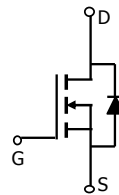
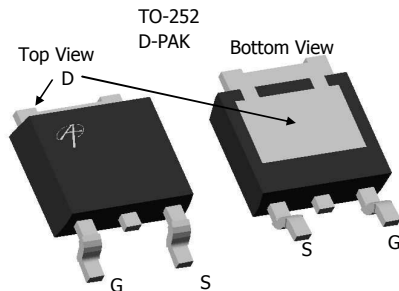
The AOD460 uses advanced trench technology and design to provide excellent  $R_{DS(ON)}$  with low gate charge. This device is suitable for use in PWM, load switching and general purpose applications.

- RoHS Compliant
- Halogen Free\*

#### Features

$V_{DS}$  (V) = 25V  
 $I_D$  = 25 A ( $V_{GS}$  = 10V)  
 $R_{DS(ON)}$  < 14 m $\Omega$  ( $V_{GS}$  = 10V)  
 $R_{DS(ON)}$  < 24 m $\Omega$  ( $V_{GS}$  = 4.5V)

**100% UIS Tested!**  
**100% Rg Tested!**



#### Absolute Maximum Ratings $T_A=25^\circ\text{C}$ unless otherwise noted

| Parameter                                      | Symbol                  | Maximum    | Units            |
|--|-------------------------|------------|------------------|
| Drain-Source Voltage                           | $V_{DS}$                | 25         | V                |
| Gate-Source Voltage                            | $V_{GS}$                | $\pm 20$   | V                |
| Continuous Drain Current <sup>G</sup>          | $T_C=25^\circ\text{C}$  | 25         | A                |
|  | $T_C=100^\circ\text{C}$ | 20         |                  |
| Pulsed Drain Current <sup>C</sup>              | $I_{DM}$                | 70         |                  |
| Avalanche Current <sup>C</sup>                 | $I_{AR}$                | 20         | A                |
| Repetitive avalanche energy 0.1mH <sup>C</sup> | $E_{AR}$                | 20         | mJ               |
| Power Dissipation <sup>B</sup>                 | $T_C=25^\circ\text{C}$  | 30         | W                |
|  | $T_C=100^\circ\text{C}$ | 15         |                  |
| Power Dissipation <sup>A</sup>                 | $T_A=25^\circ\text{C}$  | 2.5        | W                |
|  | $T_A=70^\circ\text{C}$  | 1.6        |                  |
| Junction and Storage Temperature Range         | $T_J, T_{STG}$          | -55 to 175 | $^\circ\text{C}$ |

#### Thermal Characteristics

| Parameter                                | Symbol          | Typ          | Max | Units              |
|--|-----------------|--------------|-----|--------------------|
| Maximum Junction-to-Ambient <sup>A</sup> | $R_{\theta JA}$ | 15           | 20  | $^\circ\text{C/W}$ |
| Maximum Junction-to-Ambient <sup>A</sup> |                 | Steady-State | 41  |                    |
| Maximum Junction-to-Case <sup>B</sup>    | $R_{\theta JC}$ | 3.6          | 5   | $^\circ\text{C/W}$ |

Electrical Characteristics (T<sub>J</sub>=25°C unless otherwise noted)

| Symbol                      | Parameter                             | Conditions  | Min                                | Typ  | Max    | Units |
|-----------------------------|---------------------------------------|---|------------------------------------|------|--------|-------|
| <b>STATIC PARAMETERS</b>    |                                       |   |                                    |      |        |       |
| BV <sub>DSS</sub>           | Drain-Source Breakdown Voltage        | I <sub>D</sub> =250μA, V <sub>GS</sub> =0V  | 25                                 |      |        | V     |
| I <sub>DSS</sub>            | Zero Gate Voltage Drain Current       | V <sub>DS</sub> =20V, V <sub>GS</sub> =0V<br>T <sub>J</sub> =55°C                             |                                    |      | 1<br>5 | μA    |
| I <sub>GSS</sub>            | Gate-Body leakage current             | V <sub>DS</sub> =0V, V <sub>GS</sub> =±20V  |                                    |      | 100    | nA    |
| V <sub>GS(th)</sub>         | Gate Threshold Voltage                | V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> =250μA                                      | 1                                  | 1.8  | 2.5    | V     |
| I <sub>D(ON)</sub>          | On state drain current                | V <sub>GS</sub> =10V, V <sub>DS</sub> =5V   | 70                                 |      |        | A     |
| R <sub>DS(ON)</sub>         | Static Drain-Source On-Resistance     | V <sub>GS</sub> =10V, I <sub>D</sub> =20A   |                                    | 11.5 | 14     | mΩ    |
|                             |                                       | T <sub>J</sub> =125°C   |                                    | 17.7 |        |       |
|                             |                                       | V <sub>GS</sub> =4.5V, I <sub>D</sub> =20A  |                                    | 19.2 | 24     | mΩ    |
| g <sub>FS</sub>             | Forward Transconductance              | V <sub>DS</sub> =5V, I <sub>D</sub> =20A  |                                    | 18.9 |        | S     |
| V <sub>SD</sub>             | Diode Forward Voltage                 | I <sub>S</sub> =1A, V <sub>GS</sub> =0V   |                                    | 0.74 | 1      | V     |
| I <sub>S</sub>              | Maximum Body-Diode Continuous Current |   |                                    |      | 25     | A     |
| <b>DYNAMIC PARAMETERS</b>   |                                       |   |                                    |      |        |       |
| C <sub>iss</sub>            | Input Capacitance                     | V <sub>GS</sub> =0V, V <sub>DS</sub> =12.5V, f=1MHz   |                                    | 830  | 1000   | pF    |
| C <sub>oss</sub>            | Output Capacitance                    |   |                                    | 224  |        | pF    |
| C <sub>riss</sub>           | Reverse Transfer Capacitance          |   |                                    | 127  |        | pF    |
| R <sub>g</sub>              | Gate resistance                       | V <sub>GS</sub> =0V, V <sub>DS</sub> =0V, f=1MHz  |                                    | 0.93 | 1.5    | Ω     |
| <b>SWITCHING PARAMETERS</b> |                                       |   |                                    |      |        |       |
| Q <sub>g</sub> (10V)        | Total Gate Charge                     | V <sub>GS</sub> =10V, V <sub>DS</sub> =12.5V, I <sub>D</sub> =20A                             |                                    | 15.3 | 19     | nC    |
| Q <sub>g</sub> (4.5V)       | Total Gate Charge                     |   |                                    | 7.4  | 9      | nC    |
| Q <sub>gs</sub>             | Gate Source Charge                    |   |                                    | 2.7  |        | nC    |
| Q <sub>gd</sub>             | Gate Drain Charge                     |   |                                    | 4.3  |        | nC    |
| t <sub>D(on)</sub>          | Turn-On DelayTime                     | V <sub>GS</sub> =10V, V <sub>DS</sub> =12.5V,<br>R <sub>L</sub> =0.625Ω, R <sub>GEN</sub> =3Ω |                                    | 8    |        | ns    |
| t <sub>r</sub>              | Turn-On Rise Time                     |   |                                    | 11.7 |        | ns    |
| t <sub>D(off)</sub>         | Turn-Off DelayTime                    |   |                                    | 30   |        | ns    |
| t <sub>f</sub>              | Turn-Off Fall Time                    |   |                                    | 11   |        | ns    |
| t <sub>rr</sub>             | Body Diode Reverse Recovery Time      |   | I <sub>F</sub> =20A, dI/dt=100A/μs |      | 23.5   | 30    |
| Q <sub>rr</sub>             | Body Diode Reverse Recovery Charge    | I <sub>F</sub> =20A, dI/dt=100A/μs  |                                    | 12.8 |        | nC    |

A: The value of R<sub>θJA</sub> is measured with the device mounted on 1in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with T<sub>A</sub>=25°C. The Power dissipation P<sub>DSM</sub> is based on R<sub>θJA</sub> and the maximum allowed junction temperature of 150°C. The value in any given application depends on the user's specific board design, and the maximum temperature of 175°C may be used if the PCB allows it.

B: The power dissipation P<sub>D</sub> is based on T<sub>J(MAX)</sub>=175°C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

C: Repetitive rating, pulse width limited by junction temperature T<sub>J(MAX)</sub>=175°C.

D: The R<sub>θJA</sub> is the sum of the thermal impedance from junction to case R<sub>θJC</sub> and case to ambient.

E: The static characteristics in Figures 1 to 6 are obtained using <300 μs pulses, duty cycle 0.5% max.

F: These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of T<sub>J(MAX)</sub>=175°C.

G: The maximum current rating is limited by bond-wires.

H: These tests are performed with the device mounted on 1 in 2 FR-4 board with 2oz. Copper, in a still air environment with T<sub>A</sub>=25°C. The SOA curve provides a single pulse rating.

\*This device is guaranteed green after data code 8X11 (Sep 1<sup>ST</sup> 2008).

Rev 3: Sep 2008

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TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

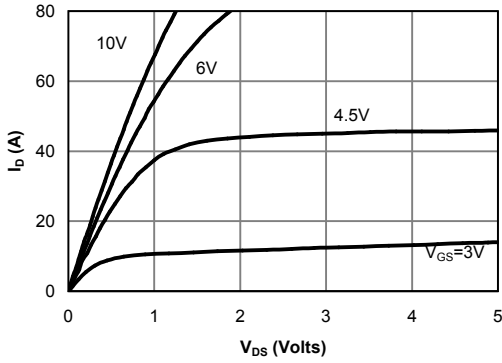


Fig 1: On-Region Characteristics

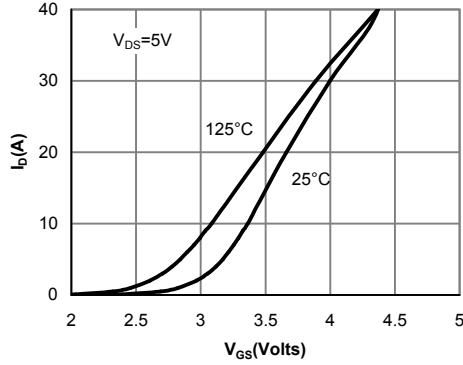


Figure 2: Transfer Characteristics

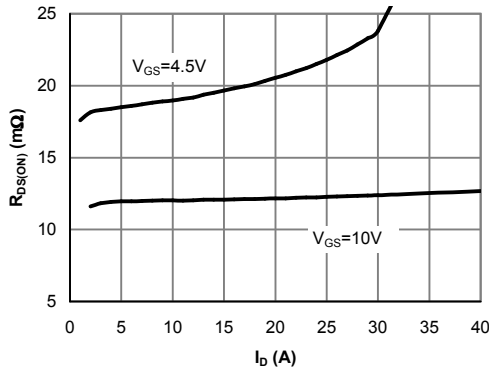


Figure 3: On-Resistance vs. Drain Current and Gate Voltage

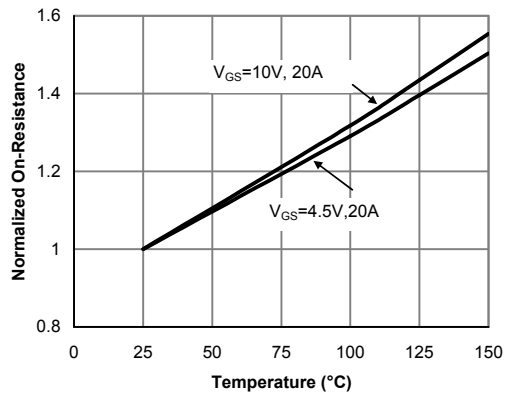


Figure 4: On-Resistance vs. Junction Temperature

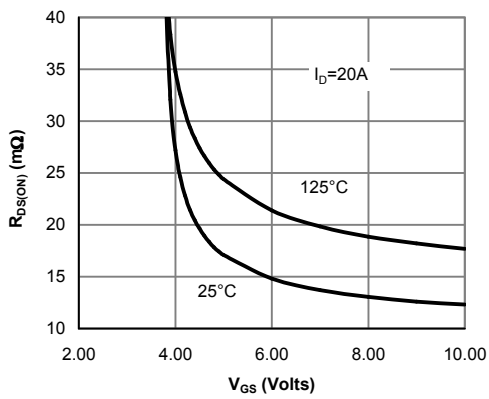


Figure 5: On-Resistance vs. Gate-Source Voltage

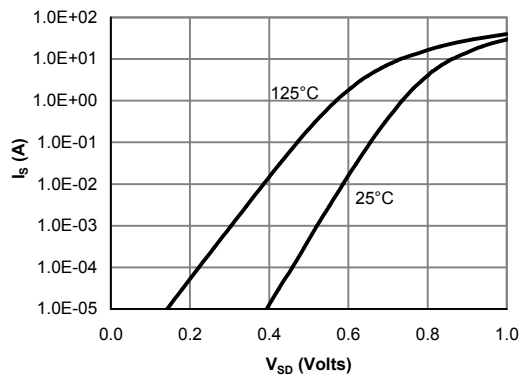


Figure 6: Body-Diode Characteristics

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

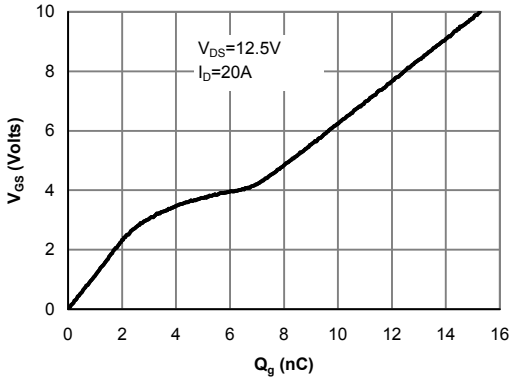


Figure 7: Gate-Charge Characteristics

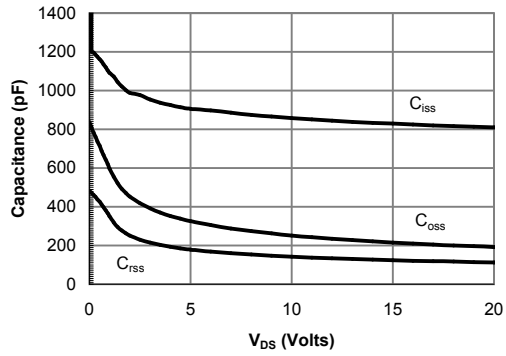


Figure 8: Capacitance Characteristics

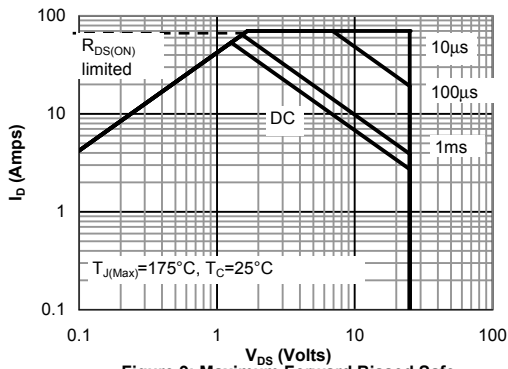


Figure 9: Maximum Forward Biased Safe Operating Area (Note E)

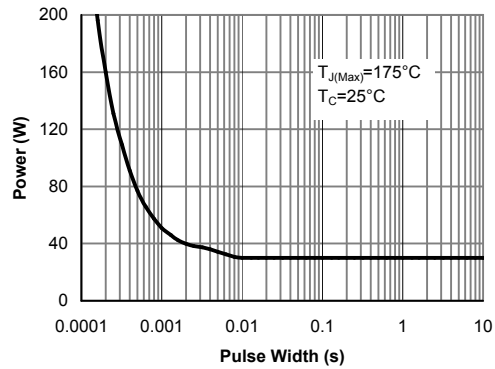


Figure 10: Single Pulse Power Rating Junction-to-Case (Note F)

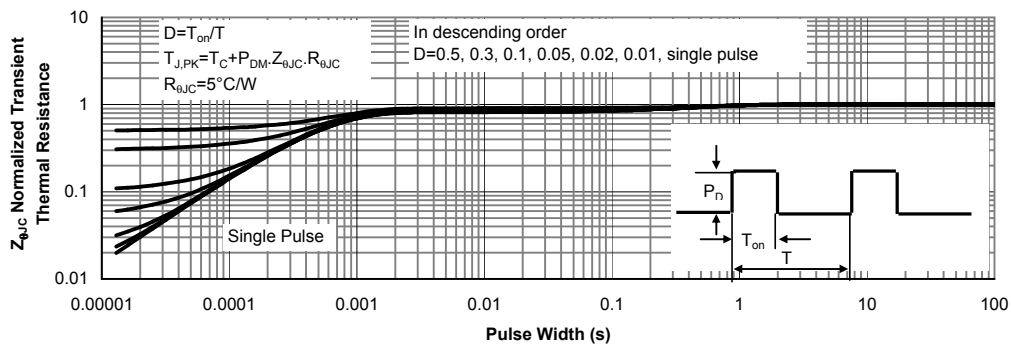


Figure 11: Normalized Maximum Transient Thermal Impedance (Note F)

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

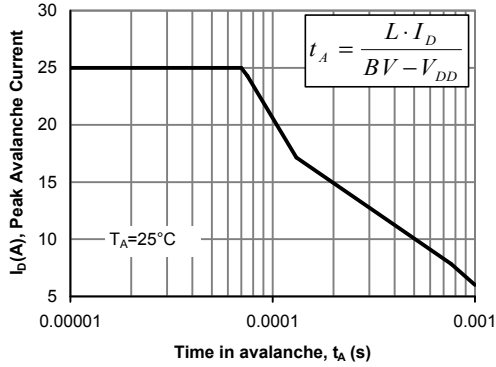


Figure 12: Single Pulse Avalanche capability

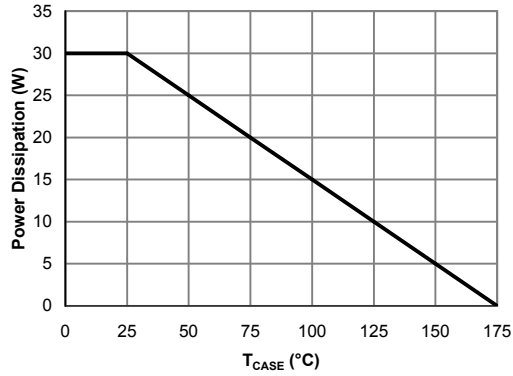


Figure 13: Power De-rating (Note B)

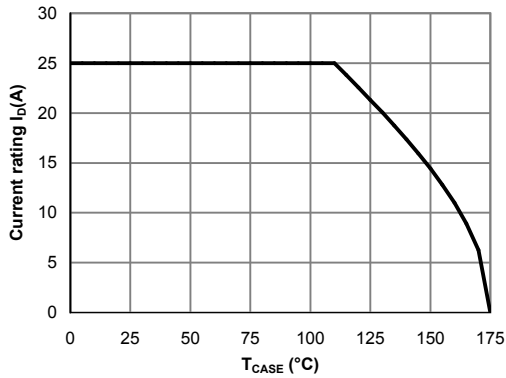


Figure 14: Current De-rating (Note B)

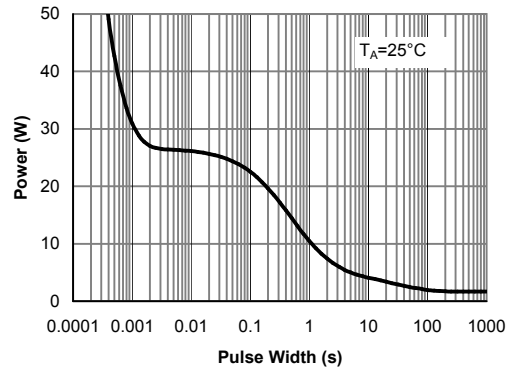


Figure 15: Single Pulse Power Rating Junction-to-Ambient (Note H)

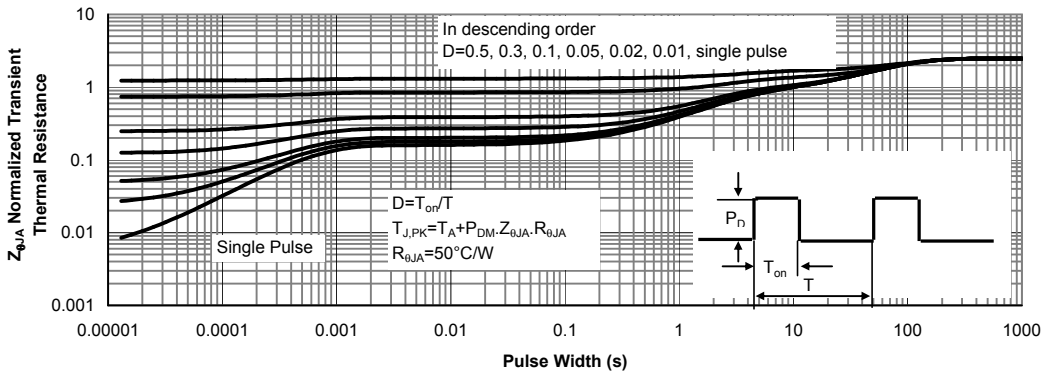
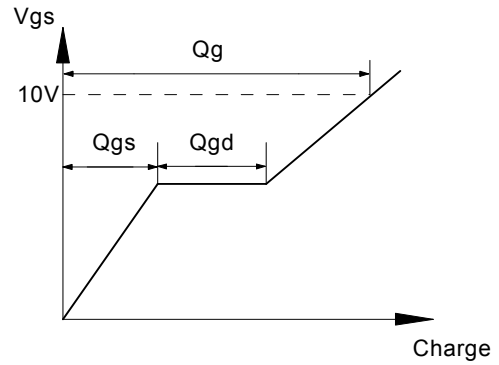
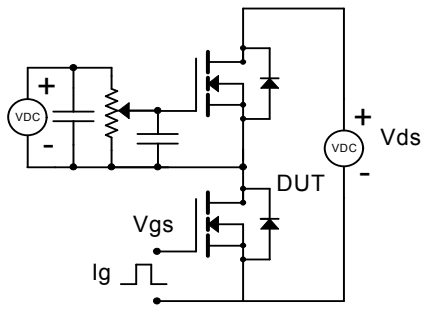
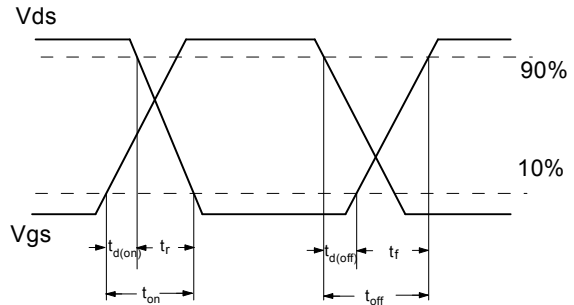
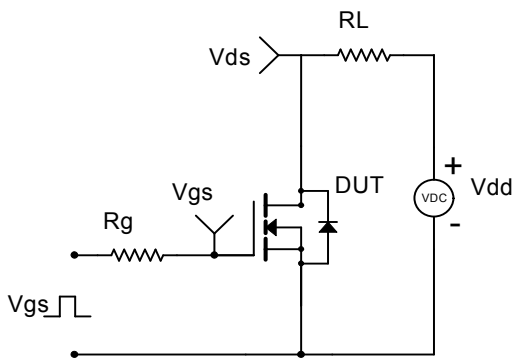


Figure 16: Normalized Maximum Transient Thermal Impedance (Note H)

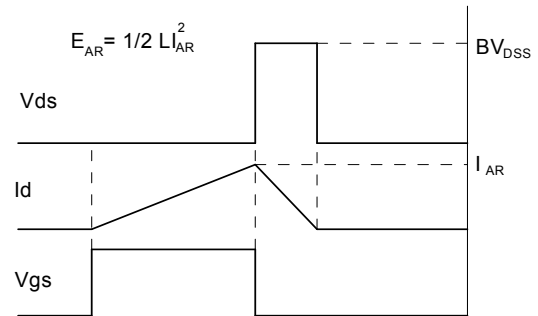
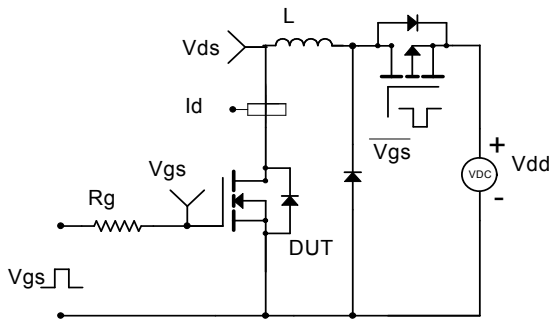
Gate Charge Test Circuit & Waveform



Resistive Switching Test Circuit & Waveforms



Unclamped Inductive Switching (UIS) Test Circuit & Waveforms



Diode Recovery Test Circuit & Waveforms

